TOSHIBA Bipolar Digital Integrated Circuit Silicon Monolithic

ULQ2003AP,ULQ2003AFW (Manufactured by Toshiba Malaysia)

7-ch Darlington Sink Driver

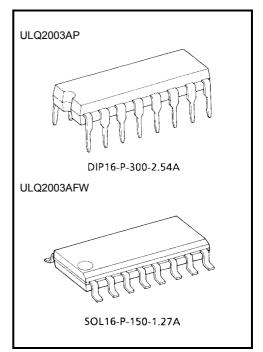
The ULQ2003AP/AFW are high-voltage, high-current darlington drivers comprised of seven NPN darlington pairs.

All units feature integral clamp diodes for switching inductive loads.

Applications include relay, hammer, lamp and display (LED) drivers.

Features

- Output current (single output): 500 mA max
- High sustaining voltage output: 50 V max
- Operating temperature: Ta = -40 to 105°C
- Output clamp diodes
- Inputs compatible with various types of logic
- Package type-AP: DIP-16pin
- Package type-AFW: SOL-16pin

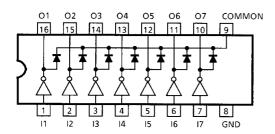


Weight

DIP16-P-300-2.54A : 1.11 g (typ.) SOL16-P-150-1.27A : 0.15 g (typ.)

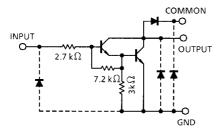
Туре	Input Base Resistor	Designation
ULQ2003AP/AFW	2.7 kΩ	TTL, 5 V CMOS

Pin Connection (top view)





Schematics (each driver)



Note: The input and output parasitic diodes cannot be used as clamp diodes.

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Output sustaining voltage		V _{CE} (SUS)	-0.5 to 50	V	
Output current		lout	500	mA/ch	
Input voltage		V _{IN}	-0.5 to 30	V	
Clamp diode reverse voltage		V_{R}	50	V	
Clamp diode forward current		l _F	500	mA	
	AP		1.47	W	
Power dissipation	AFW	P _D	0.54/0.625 (Note)		
Operating Temperature		T _{opr}	-40 to 105	°C	
Storage Temperature		T _{stg}	-55 to 150	°C	

Note: On glass epoxy PCB ($30 \times 30 \times 1.6$ mm Cu 50%)

Recommended Operating Conditions ($Ta = -40 \text{ to } 105^{\circ}\text{C}$)

Charact	eristics	Symbol	Test Condition		Min	Тур.	Max	Unit	
Output sustaining volt	age	V _{CE} (SUS)			0	_	50	V	
Output current	AP	- Іоит	$T_{pw} = 25 \text{ ms}$	Duty = 10%	0	_	200		
	AP		7 Circuits	Duty = 50%	0	_	50	mA/ch	
	AFW		Ta = 105°C	Duty = 10%	0	_	100	IIIAVCII	
	AFVV		T _j = 120°C	Duty = 50%	0	_	25		
Input voltage	•	V _{IN}		•	0	_	24	V	
Input voltage (output	on)	V _{IN (ON)}	I _{OUT} = 400 mA	A, h _{FE} = 1000	2.8	_	24	V	
Input voltage (output	off)	V _{IN (OFF)}			0	_	0.7	V	
Clamp diode reverse	voltage	V _R			_	_	50	V	
Clamp diode forward	current	I _F			_	_	350	mA	
Dower discipation	AP	D _D	Ta = 105°C		_	_	0.52	W	
Power dissipation	AFW	P _D	Ta = 105°C	(Note)	_	_	0.22	VV	

2

Note: On glass epoxy PCB ($30 \times 30 \times 1.6$ mm Cu 50%)



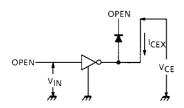
Electrical Characteristics (Ta = 25°C unless otherwise noted)

Characteristic	Symbol	Test Circuit	Test Condition		Min	Тур.	Max	Unit
Output leakage current	ICEX	1	V _{CE} = 50 V, Ta = 25°C		_	_	50	μА
Output leakage current			$V_{CE} = 50 \text{ V},$	V _{CE} = 50 V, Ta = 105°C		_	100	
	V _{CE} (sat)	2	$I_{OUT}=350$ mA, $I_{IN}=500$ μA		_	1.3	1.6	٧
Collector-emitter saturation voltage			$I_{OUT} = 200 \text{ mA}, I_{IN} = 350 \mu\text{A}$		_	1.1	1.3	
			$I_{OUT} = 100 \text{ mA}, I_{IN} = 250 \mu\text{A}$		_	0.9	1.1	
DC current transfer ratio	h _{FE}	2	$V_{CE} = 2 \text{ V}, I_{OUT} = 350 \text{ mA}$		1000	_	_	
Input current (output on)	I _{IN (ON)}	3	V _{IN} = 2.4 V, I _{OUT} = 350 mA		_	0.4	0.7	mA
Input current (output off)	I _{IN (OFF)}	4	I _{OUT} = 500 μA, Ta = 85°C		50	65	_	μА
Input voltage (output on)	V _{IN} (ON)	5	V _{CE} = 2 V	I _{OUT} = 350 mA	_	_	2.6	V
			h _{FE} = 1000	I _{OUT} = 200 mA	_	_	2.0	
Clamp diode reverse current	I _R	6	V _R = 50 V, Ta = 25°C		_	_	50	
			V _R = 50 V, Ta = 105°C		_	_	100	μΑ
Clamp diode forward voltage	V _F	7	I _F = 350 mA		_	_	2.2	V
Input capacitance	C _{IN}	_			_	15	_	pF
Turn-on delay	ton	8	V_{OUT} = 50 V, R_L = 125 Ω C_L = 15 pF		_	0.1	_	0
Turn-off delay	t _{OFF}	8	V_{OUT} = 50 V, R_L = 125 Ω C_L = 15 pF		_	0.6	—	μS

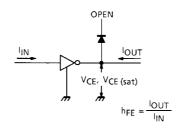
3

Test Circuit

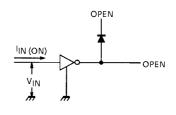
1. I_{CEX}



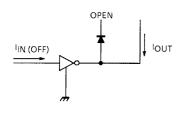
2. VCE (sat), hFE



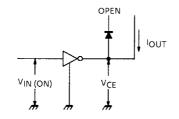
3. I_{IN (ON)}



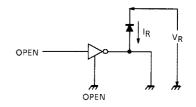
4. I_{IN} (OFF)



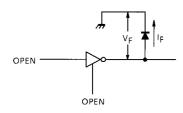
5. V_{IN} (ON)



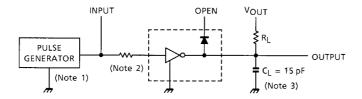
6. I_R

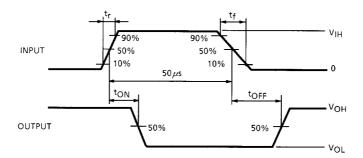


7. V_F



8. ton, toff





Note 1: Pulse width 50 μ s, duty cycle 10%

Output impedance 50 Ω , $t_r \le 5$ ns, $t_f \le 10$ ns

Note 2: See below

Input Condition

Type Number	R1	V _{IH}
ULQ2003AP/AFW	0	3 V

Note 3: C_L includes probe and jig capacitance.

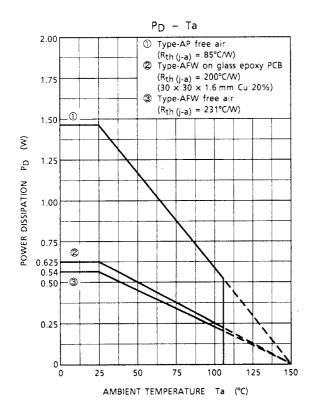
Precautions for Using

This IC does not include built-in protection circuits for excess current or overvoltage.

If this IC is subjected to excess current or overvoltage, it may be destroyed.

Hence, the utmost care must be taken when systems which incorporate this IC are designed.

Utmost care is necessary in the design of the output line, COMMON and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.



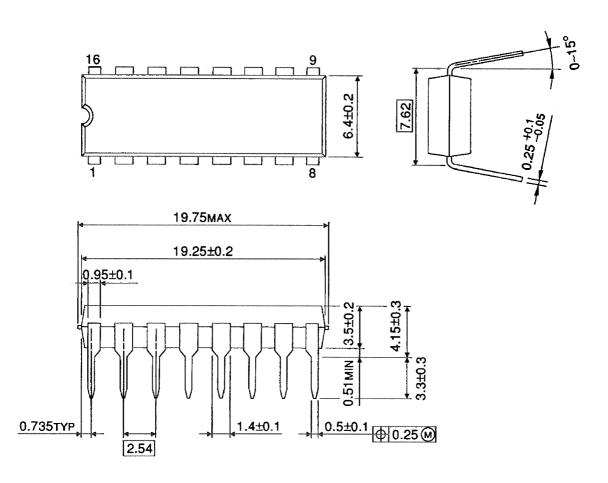
2003-03-20

6

Package Dimensions

TOSHIBA

DIP16-P-300-2.54A Unit: mm

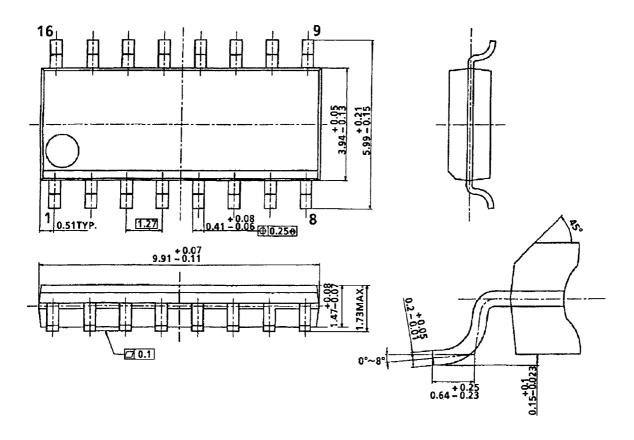


7

Weight: 1.11 g (typ.)

Package Dimensions

SOL16-P-150-1.27A Unit: mm



8

Weight: 0.15 g (typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.